

<b>Notice of References Cited</b>	Application/Control No. 09/872,582	Applicant(s)/Patent Under Reexamination PURI ET AL.	
	Examiner Cynthia Britt	Art Unit 2133	Page 1 of 1

#### U.S. PATENT DOCUMENTS

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	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Abramovici et al. in "Digital Systems Testing and Testable Design" IEEE Press 1990
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